



<p>Searched</p> 	<p>Application/Control No.</p> <p>10534496</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LANG ET AL.</p>
	<p>Examiner</p> <p>Fulton, Christopher W</p>	<p>Art Unit</p> <p>2859</p>

Class	SubClass	Date	Examiner
33	379	9/11/06	CWF

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Search Notes 	Application/Control No. 10534496	Applicant(s)/Patent Under Reexamination LANG ET AL.
	Examiner Fulton, Christopher W	Art Unit 2859

Notes	Date	Examiner
Text Search Attached	9/11/06	CWF
Text Search Attached	9/28/06	CWF

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